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INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

(Chapter II of the Patent Cooperation Treaty)

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference PU030259 FOR FURTH		FOR FURTHER	ACTION	See Form PCT/IPEA/416
International application No. International filing PCT/US2004/010789 07.04.2004				Priority date (day/month/year) 29.08.2003
International Patent Cl G06T5/10	assification (IPC) or na	tional classification an	d IPC	
Applicant THOMSON LICEN	SING S.A.et al			
This report is the Authority under the Au	he international preli	minary examination	report, established by	this International Preliminary Examining
	consists of a total of	The second of the second	and according to Artici	e 36.
3. This report is a	lso accompanied by	ANNEXES compris	This cover sheet.	•
a. 🛛 sent to	the applicant and to	the International Ru	sing: reau) a total of 3 she	
and	EIS Of the description	n, claims and/or dray		ets, as follows: n amended and are the basis of this report r (see Rule 70.16 and Section 607 of the
□ she	ets which supersede	earlier chasts but		onsiders contain an amendment that goes ndicated in item 4 of Box No. I and the
b. □ <i>(sent to</i> sequenc Box Rel	the International Bure listing and/or table ating to Sequence Li	reau only) a total of (s related thereto, in sting (see Section 8	indicate type and nun computer readable fo 02 of the Administrati	nber of electronic carrier(s)) , containing a rm only, as indicated in the Supplemental ve Instructions).
4. This report cont	ains indications relat	ting to the following	items:	
Box No. I	Basis of the opinio	n		
☐ Box No. II	Priority			
☐ Box No. III	Non-establishmen	t of opinion with reg	ard to novelty, inventiv	ve step and industrial applicability
☐ Box No. IV	Lack of utility of the	ention		• 1
⊠ Box No. V		no and explanations	with regard to nove supporting such stat	lty, inventive step or industrial
☐ Box No. VI	Certain documents	cited		
☐ Box No. VII	Certain defects in t	he international app	lication	before ,-
C Box No. VIII	Certain observation	ns on the internation	al application	1.
ate of submission of the	e demand		Date of completion of	
4.03.2005		Date of completion of	mis report	
		12.09.2005		
ame and mailing address of the international reliminary examining authority:		Authorized Officer .		
European Patent Office			portugues Patraneon.	
D-80298 Munich Tel. +49 89 2399 - 0 Tx: 523656 epmu d Fax: +49 89 2399 - 4465		Eckert, L		
		Telephone No. +49 89	2399-7631	

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No. PCT/US2004/010789

_	Во	x No. I	Basis of the r	eport	
1	. Wit	th regard d, unles	d to the languaç s otherwise indi	ge, this report is based cated under this item.	on the international application in the language in which it was
		WHICH	is the language	of a translation furnish	original language into the following language , ed for the purposes of:
		☐ inte	rnational search lication of the in	n (under Rules 12.3 and ternational application	d 23.1(b))
2.		- ~	imilianted to the	s* of the international a receiving Office in resp nd are not annexed to	application, this report is based on (replacement sheets which ponse to an invitation under Article 14 are referred to in this this report):
	Des	cription	, Pages		
	1-7			as originally filed	·
	Clai	ms, Nun	nbers		•
	1-12	2 -		received on 07.03.	.2005 with letter of 04.03.2005
	Drawings, Sheets				
	1/2, 2	2/2		as originally filed	,
•		a seque	ence listing and/	or any related table(s)	- see Supplemental Box Relating to Sequence Listing
3.				resulted in the cancell	lation of:
		☐ the d	description, pago claims, Nos.		
		☐ the s	drawings, sheets sequence listing	(specify):	
		□ any t	table(s) related	to sequence listing (sp	ecify):
4.	iiuu i	HOLDEGI	ort has been es n made, since thal Box (Rule 70.	iev nave neen conside	of) the amendments annexed to this report and listed below ered to go beyond the disclosure as filed, as indicated in the
		☐ the d	lescription, page laims, Nos.		
	ł	🗆 the d	rawings, sheets	<i>f</i> ligs	. 445.70 O 2016 th
	ĺ	o the s or any t	equence listing able(s) related t	<i>(specify)</i> : o sequence listing <i>(spe</i>	ecny).
	* 1	If ite	n 4 applies,	some or all of t	these sheets may be marked "superseded."

Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

1. Statement

Novelty (N)

Yes: Claims

1-12

No: Claims

Inventive step (IS)

Yes: Claims

1-12

No: Claims

Industrial applicability (IA)

Yes: Claims

1-12

No: Claims

2. Citations and explanations (Rule 70.7):

see separate sheet

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Re. item V:

- Reference is made to the following document:
 D1: US-A-5 641 596 (COK DAVID R ET AL) 24 June 1997 (1997-06-24)
- 2. Since none of the documents cited in the International Search Report contains an indication to derive cut frequencies of 2D band-pass filters which approximate grain patterns when operated on random noise, the application seems to contain subject matter which is both novel and inventive and hence fulfills the requirements of Article 33 PCT. However, the objections listed below apply; for the assessment of novelty and inventive step, the unclear parts have been construed as stated in the following objections.

Clarity:

- 3. The application does not meet the requirements of Article 6 PCT, because claims 1, 6 8 and 10 12 are not clear.
- 3.1. Re. independent claims 1 and 12: It is not clear how film grain samples can be transformed, since these could also exist as chemical structures. According to the description, p. 1, I. 17 28, the claims should have been directed to a method for modeling film grain patterns in a digital image.
- 3.2. Re. dependent claims 6, 7, 10 and 11: It is obscure what the intersection point(s) should be, because it is unclear what exactly intersects the curves. The clear teaching of the description, p. 6, l. 26 p. 7, l. 26, should have been incorporated into the claims.
- 3.3. Re. dependent claim 8: In lines 8 10 of claim 8, reference is made to "a curve" and "the curve", i.e. to a single curve. Since according to the description, p. 6, l. 26 p. 7, l. 26, each of the horizontal and vertical mean vectors is represented as a curve and cut frequencies are established from said associated curves, claim 8 should have been formulated accordingly.

Further remarks:

- 4. Contrary to the provisions of R. 6.4(a) PCT and the Guidelines, 5.12 and 5.13, claims 1 and 12 are drafted as separate independent method claims. Since claim 12 furthermore contains all the features of independent claim 1, claim 12 should have been drafted as a claim dependent on claim 1, cf. R. 6.4(a) PCT and the Guidelines, 5.15.
- Contrary to the provisions of Rule 6.2(b) PCT, the features of the claims are not provided with reference signs placed in parentheses.
- 6. The description, p. 7, l. 21f. states that like numerals were used in fig.s 1 and 2, but actually, both figures do not have any numerals in common. As a consequence, the reference to "steps 107 and 108" (cf. p. 7, l. 24) is incorrect.
- Contrary to the requirements of Rule 5.1(a)(ii) PCT, the documents D1 is neither identified in the description, nor is the relevant background art disclosed therein briefly discussed.

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•		CIADAG
1	1.	CLAIMS A method for automatically modeling film grain patterns, comprising the steps of:
2		transforming a set of film grain samples, comprised of at least one group of neighboring
3	pixels	that retains information about film grain shape and size, to the frequency domain;
4		storing each set of coefficients resulting from such transform, the coefficients forming
5	pattern	
6		analyzing the pattern created by the transform coefficients; and
7	-	estimating the cut frequencies of a 2D band-pass filter that can simulate the pattern of
8	transfo	orm coefficients by filtering random noise in a frequency domain.

- 1 2. The method according to claim 1 further comprising the step of transmitting at least one cut frequency in a Supplemental Enhancement Information message.
- 1 3. The method according to claim 1 wherein the film grain samples are processed in 2 blocks of N x N pixels.
- 4. The method according to claim 3 wherein the step of analyzing the pattern created by the transform coefficients further comprises the steps of:

 computing a mean block of N x N transform coefficients by averaging the transform
 - coefficients from all the stored blocks following a transformation of each N x N pixel block; defining horizontal and vertical mean vectors of N components each by averaging the mean block of N x N coefficients along rows and columns, respectively;
 - representing the horizontal and vertical mean vectors as separate curves; and establishing horizontal and vertical cut frequencies from the curves represented by the horizontal and vertical mean vectors, respectively.
- 1 5. The method according to claim 4 further comprising the step of low pass filtering at least one mean vector.
- 1 6. The method according to claim 4 wherein one of the horizontal and vertical cut 2 frequencies is established from an intersection point in the curve representing a corresponding 3 one of the mean horizontal and vertical vectors, respectively.

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mean vector.

1	7.	The method according to claim 4 wherein each of a low and	a high horizontal and
2	vertical cut fr	equencies is established from a first and second intersection po	oints in the curve
3	representing (he mean horizontal and vertical vectors, respectively.	-

- by the transform coefficients further comprises the steps of:

 computing a mean block of N x N transform coefficients by averaging the transform coefficients from all the stored blocks following a transformation of each pixel block; defining horizontal and vertical mean vectors of N components each by averaging the mean block of N x N transform coefficients along rows and columns, respectively; averaging the horizontal and vertical mean vectors into a single mean vector; representing the mean vectors as a curve; and establishing horizontal and vertical cut frequencies from the curve represented by the
- 1 9. The method according to claim 8 further comprising the step of low pass filtering the mean vector.
- 1 10. The method according to claim 8 wherein one of a horizontal and vertical cut
 2 frequencies is established from an intersection point in the curve representing a corresponding
 3 one of the mean horizontal and vertical vectors, respectively.
- 1 11. The method according to claim 8 wherein each of a low and a high horizontal and
 2 vertical cut frequencies is established from a first and second intersection points in the curve
 3 representing the mean horizontal and vertical vectors, respectively.

1.	12. A method for automatically modeling film grain patterns, comprising the steps of:
2	receiving a set of film grain samples
3	performing a transform on the set of film grain samples, comprised of at least one group
4	of neighboring pixels that retains information about film grain shape and size, to the frequency
5	domain
6	storing each set of coefficients resulting from such transform, the coefficients forming a
?	pattern;
8	analyzing the pattern created by the transform coefficients; and
9	estimating the cut frequencies of a 2D band-pass filter that can simulate the pattern of
10	transform coefficients by filtering random noise in a frequency domain.